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**U.S. PATENT DOCUMENTS**

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
AR						
BR						
CR						
DR						
ER						
FR						
GR						
HR						
IR						
JR						
KR						
LR						
MR						
NR						

**FOREIGN PATENT DOCUMENTS**

	Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract	Translation Readily Available	
					Enclosed	No	Enclose
PK	OR 1 526 550 A1	04/2005	Europe	ASML Netherlands B.V.			
PK	PR 1 037 036 A1	09/2000	Europe	Trace Analytical			
PK	QR 0 874 283 A3	01/2000	Europe	Nikon Corporation			
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**OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)**

PK	YR	International Search Report issued for PCT Application PCT/NL2004/000927 on December 19, 2005.		
	ZR			
	AAR			
	BBR			
	CCR			

Examiner *Peter B. Kim* Date Considered: *4 / 1 / 06*

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